

#### < IGBT MODULES >

## CM200DY-34A

**HIGH POWER SWITCHING USE INSULATED TYPE** 



Collector-emitter voltage V<sub>CES</sub> ...... 1 7 0 0 V

Collector current I<sub>C</sub> .....

Maximum junction temperature T<sub>jmax</sub> ................ 1 5 0 °C

Flat base Type

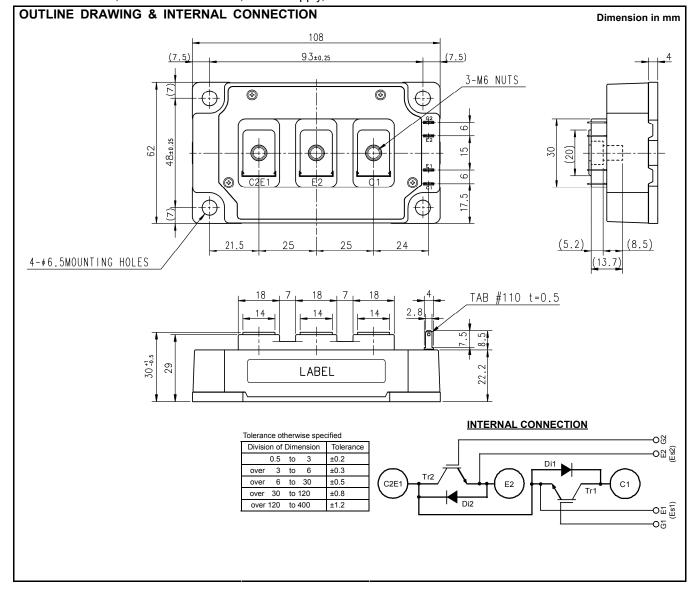
Copper base plate

•RoHS Directive compliant

•UL Recognized under UL1557, File E323585

## **APPLICATION**

AC Motor Control, Motion/Servo Control, Power supply, etc.



#### < IGBT MODULES > CM200DY-34A HIGH POWER SWITCHING USE INSULATED TYPE

ABSOLUTE MAXIMUM RATINGS (	T <sub>i</sub> =25 °C, unless otherwise specified)
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Symbol	Item	Conditions	Rating	Unit
V <sub>CES</sub>	Collector-emitter voltage	G-E short-circuited	1700	V
$V_{GES}$	Gate-emitter voltage	C-E short-circuited	±20	V
Ic	Collector current	DC, T <sub>C</sub> =109 °C (Note.2, 4)	200	۸
I <sub>CRM</sub>	- Collector current	Pulse, Repetitive (Note.3)	400	Α
P <sub>tot</sub>	Total power dissipation	T <sub>C</sub> =25 °C (Note.2, 4)	1980	W
I <sub>E</sub> (Note.1)	- Emitter current	T <sub>C</sub> =25 °C (Note.2, 4)	200	Α
I <sub>ERM</sub> (Note.1)	- Emilier current	Pulse, Repetitive (Note.3)	400	_ A
Tj	Junction temperature	-	-40 ~ +150	°C
T <sub>stg</sub>	Storage temperature	-	-40 ~ +125	
V <sub>isol</sub>	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	3500	V

ELECTRICAL CHARACTERISTICS (T<sub>i</sub>=25 °C, unless otherwise specified)

Cumbal	Item	Conditions		Limits			Unit
Symbol	item			Min.	Тур.	Max.	Unit
I <sub>CES</sub>	Collector-emitter cut-off current	V <sub>CE</sub> =V <sub>CES</sub> , G-E short-circuited		-	-	1.0	mA
I <sub>GES</sub>	Gate-emitter leakage current	V <sub>GE</sub> =V <sub>GES</sub> , C-E short-circuited		-	-	2.0	μA
$V_{\text{GE(th)}}$	Gate-emitter threshold voltage	I <sub>C</sub> =20 mA, V <sub>CE</sub> =10 V		5.5	7.0	8.5	V
V.	Collector-emitter saturation voltage	I <sub>C</sub> =200 A (Note.5),	T <sub>j</sub> =25 °C	-	2.2	2.8	V
V <sub>CEsat</sub>	Collector-emitter saturation voltage	V <sub>GE</sub> =15 V	T <sub>j</sub> =125 °C	-	2.45	-	v
Cies	Input capacitance		V <sub>CE</sub> =10 V, G-E short-circuited		-	49.4	
Coes	Output capacitance	V <sub>CE</sub> =10 V, G-E short-circuited			-	5.6	nF
Cres	Reverse transfer capacitance				-	1.06	
Q <sub>G</sub>	Gate charge	V <sub>CC</sub> =1000 V, I <sub>C</sub> =200 A, V <sub>GE</sub> =15 V		-	1330	-	nC
t <sub>d(on)</sub>	Turn-on delay time	- V <sub>CC</sub> =1000 V, I <sub>C</sub> =200 A, V <sub>GE</sub> =±15 V,		-	-	550	ns ns
tr	Rise time			-	-	190	
t <sub>d(off)</sub>	Turn-off delay time	D =2.4.0. Industive lead		-	-	750	
t <sub>f</sub>	Fall time	$R_{G}$ =2.4 $\Omega$ , inductive load	$R_G$ =2.4 $\Omega$ , Inductive load		-	350	
V <sub>EC</sub> (Note.1)	Emitter-collector voltage	I <sub>E</sub> =200 A (Note.5), G-E short-cir	I <sub>E</sub> =200 A (Note.5), G-E short-circuited		2.3	3.0	V
t <sub>rr</sub> (Note.1)	Reverse recovery time	V <sub>CC</sub> =1000 V, I <sub>E</sub> =200 A, V <sub>GE</sub> =±1	V <sub>CC</sub> =1000 V, I <sub>E</sub> =200 A, V <sub>GE</sub> =±15 V,		-	450	ns
Q <sub>rr</sub> (Note.1)	Reverse recovery charge	R <sub>G</sub> =2.4 Ω, Inductive load	$R_G$ =2.4 $\Omega$ , Inductive load		20	-	μC
Eon	Turn-on switching energy per pulse	V <sub>CC</sub> =1000 V, I <sub>C</sub> =I <sub>E</sub> =200 A,	$V_{CC}$ =1000 V, $I_{C}$ = $I_{E}$ =200 A, $V_{GE}$ =±15 V, $R_{G}$ =2.4 $\Omega$ , $T_{j}$ =125 °C,		94.5	-	m l
E <sub>off</sub>	Turn-off switching energy per pulse	V <sub>GE</sub> =±15 V, R <sub>G</sub> =2.4 Ω, T <sub>j</sub> =125			58.7	-	mJ
E <sub>rr</sub> (Note.1)	Reverse recovery energy per pulse	Inductive load	Inductive load		50.7	-	mJ
r <sub>g</sub>	Internal gate resistance	Per switch, T <sub>c</sub> =25 °C		-	3.0	-	Ω

#### THERMAL RESISTANCE CHARACTERISTICS

Symbol Item	Itom	Conditions	Limits			Unit
	Conditions	Min.	Тур.	Max.	Offic	
$R_{th(j-c)Q}$	Thermal resistance (Note.2)	Junction to case, per IGBT	-	-	0.063	K/W
$R_{th(j-c)D}$		Junction to case, per FWDi	-	-	0.11	K/W
R <sub>th(c-s)</sub> Contact thermal resistance (Note.2)	Case to heat sink, per 1/2 module,	-	0.02	-	K/W	
	Thermal grease applied (Note.6)				IV/VV	

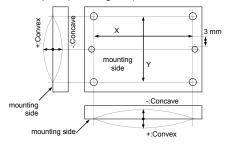
#### **MECHANICAL CHARACTERISTICS**

Symbol Item	Conditions		Limits			Unit	
Syllibol	item	Conditions		Min.	Тур.	Max.	Offic
$M_t$	Mounting torque	Main terminals	M 6 screw	3.5	4.0	4.5	N·m
Ms		Mounting to heat sink	M 6 screw	3.5	4.0	4.5	N·m
m	Weight	=		-	400	-	g
e <sub>c</sub>	Flatness of base plate	On the centerline X, Y (Note.7)		-100	-	+100	μm

- Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free wheeling diode (FWDi).
  - 2. Case temperature (T<sub>c</sub>) and heat sink temperature (T<sub>s</sub>) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

The heat sink thermal resistance should measure just under the chips.

- 3. Pulse width and repetition rate should be such that the device junction temperature (T<sub>i</sub>) dose not exceed T<sub>imax</sub> rating.
- 4. Junction temperature  $(T_j)$  should not increase beyond  $T_{jmax}$  rating.
- 5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.
- 6. Typical value is measured by using thermally conductive grease of  $\lambda$ =0.9 W/(m·K).
- 7. Base plate (mounting side) flatness measurement points (X, Y) are as follows of the following figure.

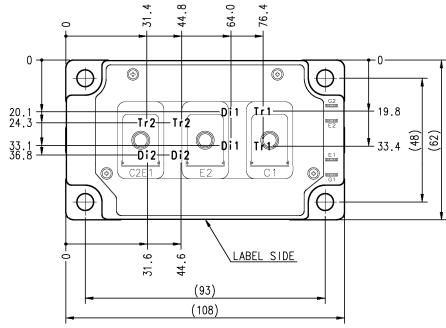


#### RECOMMENDED OPERATING CONDITIONS

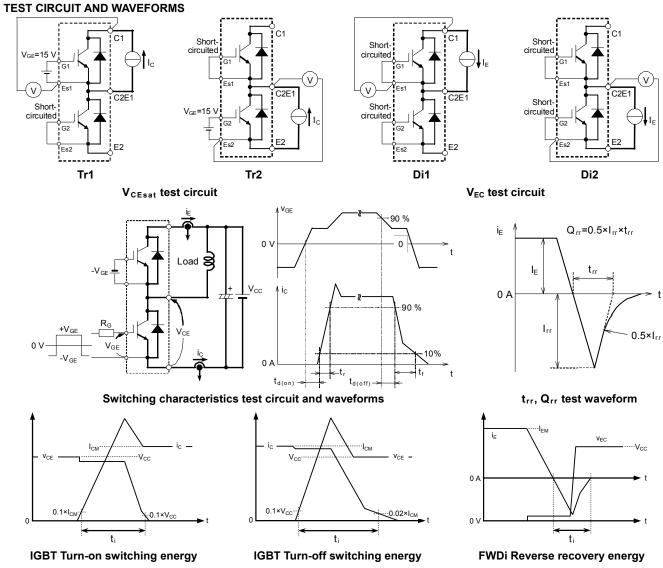
Symbol Item	Conditions	Limits			Unit	
		Min.	Тур.	Max.	Offic	
V <sub>CC</sub>	(DC) Supply voltage	Applied across C1-E2	1	1000	1100	V
$V_{GEon}$	Gate (-emitter drive) voltage	Applied across G1-Es1/G2-Es2	13.5	15.0	16.5	V
$R_G$	External gate resistance	Per switch	2.4	-	24	Ω

#### **CHIP LOCATION (Top view)**

Dimension in mm, tolerance: ±1 mm



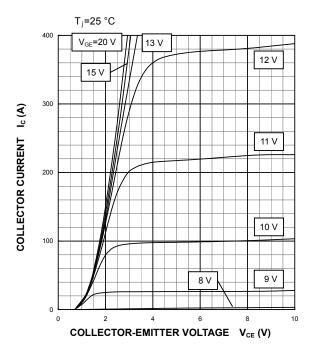
Tr1/Tr2: IGBT, Di1/Di2: FWDi



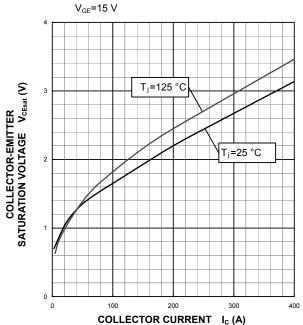
Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

#### **PERFORMANCE CURVES**

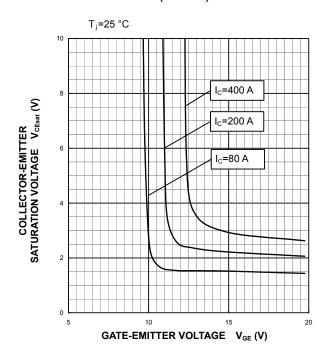
#### **OUTPUT CHARACTERISTICS** (TYPICAL)



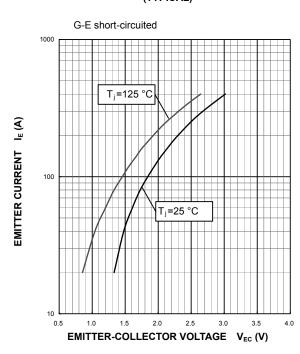
#### **COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS** (TYPICAL)



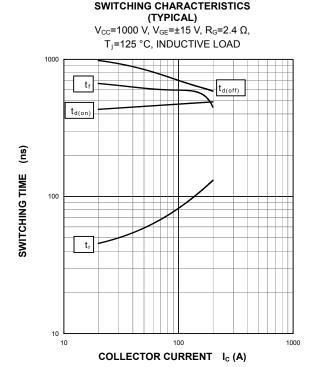
#### **COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS** (TYPICAL)



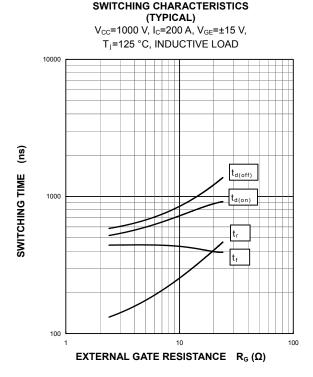
#### FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)



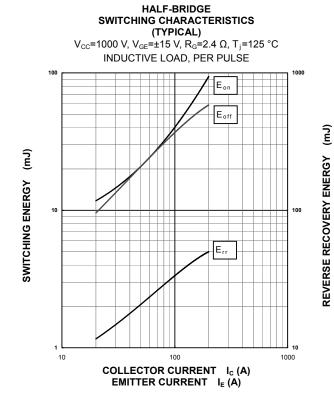
#### PERFORMANCE CURVES

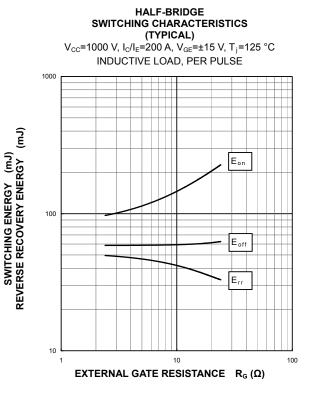


HALF-BRIDGE



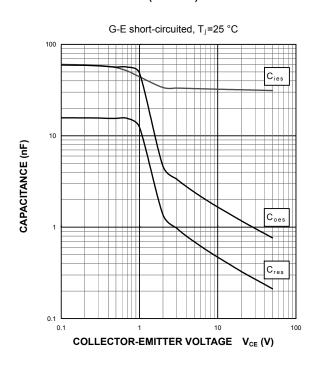
HALF-BRIDGE





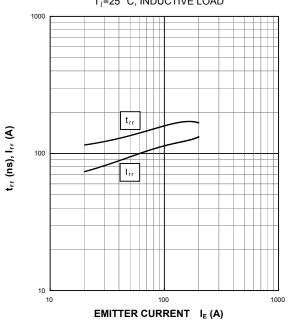
#### PERFORMANCE CURVES

## CAPACITANCE CHARACTERISTICS (TYPICAL)

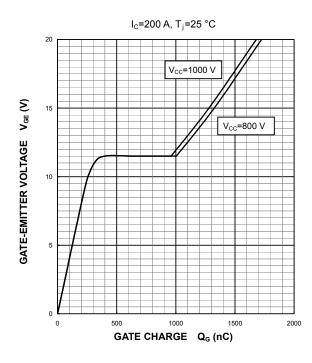


# FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

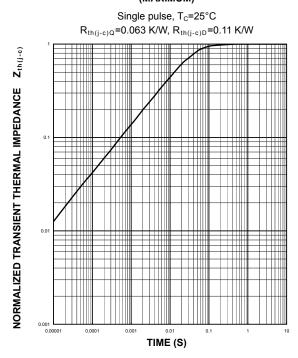
 $\begin{aligned} &V_{\text{CC}}\text{=}1000 \text{ V, } V_{\text{GE}}\text{=}\pm15 \text{ V, } R_{\text{G}}\text{=}2.4 \text{ }\Omega, \\ &T_{j}\text{=}25 \text{ }^{\circ}\text{C, INDUCTIVE LOAD} \end{aligned}$ 



## GATE CHARGE CHARACTERISTICS (TYPICAL)



## TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)



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